


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590922	<b>Applicant(s)/Patent Under Reexamination</b>  OH ET AL.
	<b>Examiner</b>  Eduardo Colon-Santana	<b>Art Unit</b>  2837

SEARCHED			
Class	Subclass	Date	Examiner
187	247, 248, 391-394, 413, 414	2/28/2009	ECS
250	221, 222.1	2/28/2009	ECS
340	541, 545.3, 555-557	2/28/2009	ECS
345	175, 177	2/28/2009	ECS
341	26	2/28/2009	ECS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST SEARCH plus TEXT SEARCH INCLUDING EPO, JPO AND DERWERT DATABASES	2/28/2009	ECS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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